Search Notes				

Application/Control No.	Applicant(s)/Patent und Reexamination	der
10/553,196	HASEGAWA ET AL.	
Examiner	Art Unit	
Iomos A Eigrita	1754	

SEARCHED				
Class	Subclass	Date	Examiner	
423	610	9/4/2007	JF	
977	811	9/4/2007	JF	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner.	

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Inventor name search	9/4/2007	JF
Foreign database text and image search	9/4/2007	JF
East text and image search (See search history)	9/4/2007 \	JF